

69 Biomedical Professionals Become Certified

Sixty-nine biomedical professionals have been awarded certification status from the International Certification Commission (ICC) and the U.S. Certification Commission (USCC).

The results are based on exams administered in November 2004. Of the 69 who earned the certification status, 61 were certified as biomedical equipment technicians (CBET), seven were certified as radiological equipment specialists (CRES), and one was certified as a laboratory equipment specialist (CLES).

In addition, 10 people passed the exam as Certification Candidates, meaning they need to gain additional experience before obtaining full certification status.

To become certified, an applicant must meet work

experience and educational requirements in biomedical equipment or electronics technology, and must accurately answer at least 105 of the 150 multiple choice questions on the test. The exam is divided into five sections: Anatomy and Physiology; Safety in the Health Care Facility; Fundamentals of Electricity, Electronics, and Solid-State Devices; Medical Equipment Function and Operation; and Medical Equipment Problem Solving.

If you have any questions regarding any aspect of the ICC Certification, contact Iman Hannon, certification coordinator for the ICC, at ihannon@aami.org. For more information about certification, visit www.aami.org/certification.

CBET

Timothy P. Angielczyk
Daniel L. Arghibeque
Raymond C. Arthur
Richard E. Bloodworth
Nathan John Brauer
Marsha R. Carter
Shawn E. Clark
Curtis V. Cook
Barry W. Cress
Jimmy D. DeLoney
Paul Foote
Douglas B. Gadeberg
William M. Gallman
Ronald L. Heath Jr.
Ivan G. Hildreth
Michael D. Holland
Billy Holloway
Travis D. Jeffries
Paula G. Jones
Benny Peter Kattungathayil
Bruce A. Kohl
Dominic Peregrin Kunnel
Jeffery L. Lamer
Donald Lanier
Lynn P. Layton
Xiaojie Liu
Lola I. Lyttle-Hill
Michael O. Martinez

Reju Mathew
Donald J. Neleigh
James Newton
Robert J. Nusbaum Jr.
Joseph M. Panczner
Michale Papa
Thomas J. Pokorny
Robert Preston
Thomas K. Price
Mark Pullen
Rafael Ramirez
Mark Remien
Stephen A. Reyes
Larry S. Riley
Dennis E. Rix
Justin S. Ross
Michael F. Russell
Gurpreet S. Saini
Majed Ribhi Saleh
Yemelyan Shipkevich
Steven M. Simon
David L. Smith
Rajnarayanan Srinivasan
Michael L. Tassler
Liju Varghese
Alberto Vasquez
V. Venkatachalam
Joseph S. Walkowiak
Wiley J. White

Brian S. Wilson
Thomas L. Winstel
Anthony Wolff
Kelly W. Wright

CLES

Roberto F. Canas

CRES

James M. Dean
Kenneth M. Farley
George E. Gallant
Pamela L. Jorgensen
William W. Mawson
William J. Schifko
Samuel T. Stephens

Candidates for Certification

Jonathan J. Albers
Babak Arvani
Suren R. Brutyan
Robert J. Frank
Brian W. Horn
Jung-Chang Huang
Frank P. Hughes
Edward J. Lauer
Adam A. Rucinski
Mona M. Sharief